

<b>Notice of References Cited</b>	Application/Control No. 09/905,792	Applicant(s)/Patent Under Reexamination CHEN, HAO-CHIH
	Examiner Jeanne A. Di Grazio	Art Unit 2871

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,533,633	03-2003	Ono, Shin-Ichirou	445/26
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2001290145	04-2000	Japan	Katsuya	G02F 1/13357
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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